Notice of References Cited Application/Control No. 10/522,577 Examiner Chau N. Nguyen Applicant(s)/Patent Under Reexamination TAKAHASHI ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,463,188	10-1995	Nohmi et al.	174/108
*	В	US-6,677,534	01-2004	Yamamoto et al.	174/113R
*	С	US-4,131,759	12-1978	Felkel, Edward M.	174/107
*	D	US-4,552,989	11-1985	Sass, Richard G.	174/103
*	Е	US-5,483,020	01-1996	Hardie et al.	174/36
*	F	US-3,163,836	12-1964	MASAO SUGI; et. al.	333/243
	G	US-			
	Ι	US-			
	_	US-			
	٦	US-			
	K	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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	s					
	Τ					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
	w	
	х	

^{*}A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.